

(b) (5) DPP, (b) (7)(C), (b) (7)(D)

Matthew W. Genack

2617

[illegible]

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
	<b>DATE</b>	<b>EXMR</b>
Consulted with Primary Examiner Ovidio Escalante	6/22/2005	M.G.
455/63.1, 455/63.4, 455/428, 455/562.1 (Limited text search---see search history printout)	6/22/2005	M.G.
Conducted keyword search with EAST (See search history printout)	6/22/2005	M.G.
Consulted with Primary Examiner Dao Phan	1/31/2006	M.G.
Consulted with Primary Examiner Gregory Issing	1/31/2006	M.G.
342/368, 342/373, 342/373 (Limited text search---see search history printout)	1/31/2006	M.G.
Updated search (See search history printout)	1/31/2006	M.G.
Updated search (See search history printout)	7/10/2006	M.G.

**Search Notes (continued)**

Application/Control No.

09/922,442

Examiner

Matthew W. Genack

Applicant(s)/Patent under  
Reexamination

LIANG ET AL.

Art Unit

2617

**SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Conducted NPL search with IEEE Explore (See printout)	7/10/2006	M.G.
Updated search (See search history printout)	4/3/2007	M.G.